

**Search Notes**

Application/Control No.

10/022,443

Examiner

Feben M. Haile

Applicant(s)/Patent under  
Reexamination

DUNN ET AL.

Art Unit

2663

**SEARCHED**

Class	Subclass	Date	Examiner
370	389	11/10/2005	FH
370	392	11/10/2005	FH
370	410	11/10/2004	FH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search: ss7, signal, message, unit class, type, destination, address, link, table, map, chart, classify	11/10/2005	FH